Model 1700 Specifications

Automatic Functions

Auto Prealignment: Capture Window: Site by Site Alignment: Placement: Overlay Alignment: Target Capture Window: Auto Focus: Focus Gauge: Auto wafer level: Autoloader: Manual Loader: Reticle Load and Align: Field Change:

System specifications

Wafer Sizes: XY Stage: Vibration Control: Computer: Printer: Throughput: Throughput; MVS System:

Lens Specifications

Lens Type: Lens Elements: Projection Ratio: Exposure Spectrum: Chromatic Correction: Alignment Spectrum: Numerical Aperature: Depth of Focus:

Field Size, 1.2um lens:

Field Size, 1.0um lens:

Illumination Specifications

Automatic Exposure Control: Lamp Type: Mercury Vapor Control: Exposure Uniformity

Reticle Specifications

Size (from standard 5"x5" plates): Pellicle Protection: KLA/NJS Inspectable: Substrate: Alignment Mark: Size: Design Flexibility: Generation Technique: Fields per reticle:

Physical Specifications

Footprint: Dimensions: Service Clearance: Weight: Facility Requirements: Ambient Temperature Control: Electrical: Nitrogen or Compressed Air: Vacuum: Exhaust: Darkfield + - 2 millimeters Darkfield < 0.13um, 2 sigma 98% < 0.16um + / - 50 microns, scanning 200 micron target Site by Site, electronic Automatic compensation for environmental fluctuations, image tilt Site by Site, electronic Cassette to Cassette, SEMI standard Input and Output slot, single wafer Less than 5 minutes 7 seconds

2", 3", 4", 5", 6", 8" Air bearing, laser metered, resolution of .00004 mm Air cushioned granite table HP332 or HP362 computer with 3.5" floppy and hard disk (362) 80 column printer, with clean room paper 55 WPH (1.0um lens), 45 WPH (0.8um lens) 50 WPH (1.0um lens), 40 WPH (0.8um lens)

Catadioptric 5 Total in two groups 1:1 Broadband, 390nm-450nm Throughout exposure spectrum 500nm-650nm variable, .18NA thru .40NA 4.0 ums @ 1.2 um lines, 16 um DOF @ 4.0 um lines for 1.2 um lens 3.0 ums @ 1.0 um lines, 14 um DOF @ 4.0 um lines for 1.0 um lens Max area rectangle = 34.2 mm x 13.6 mm Longest rectangle = 34.2 mm x 13.6 mm Max area rectangle = 34.2 mm x 13.6 mm Longest rectangle = 34.2 mm x 13.6 mm Longest rectangle = 39 mm x 11.4 mm Largest square, 18 mm x 18 mm

Integrated dose monitored for exposure repeatability 200 watt mercury arc, pulsed to 500 watts during exposure Built in +/- 2.5%

3" x 5" x 0.090" and 5" x 5" x 0.090" Chrome Side Yes, 4 identical rows Quartz or low expansion Scribe Area 200um square standard, optional crossmask size allows reduction of mark to 70um minimum Verticle or Horizontal alignment marks E-Beam or optical step and repeat 2 fields standard, up to 7 fields total (requires optional hardware)

14 feet square 46" width x 50" depth x 78" height Allow 24" on all sides, and in back 3000 lbs No environmental chamber required 70 degrees , +/- 2 degrees fahrenheit 115 volts, 50/60 Hz, 15 Amps, Inrush current, 35 Amps for 100 milliseconds Minimum 80 psi, 2 CFM, Dry to -40 degrees F dewpoint, filtered to 0.2 microns One line, minimum 20" Hg, 2 CFM Single exhaust to 3 - 10 CFM at 0.1" H20

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